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Substitute for Fe	orm 1449A/PTO		-	Complete If Known		
				Application Number	\$ 10/602,910	
	MATION D			Filing Date	June 24, 2003	
STATEMENT BY APPLICANT				First Named Inventor	SHUICHI TAKAYAMA ET AL.	
				Group Art Unit	1744	
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Sheet	1	of	3	Attorney Docket Number	UOM 0272 PUSP	

				U.S. PATENT DO	CUMENTS	
Examiner Initials	Cite No.1	Ù.S. PATENT (NOCUMENT Kind Code ² (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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^{*}EXAMINER: tnitial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered, include copy of this form with next communication to applicant.

¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.



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				Applicati n Number	\$10/602,910			
	RMATION E			Filing Date	June 24, 2003			
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	·		· ,	Group Art Unit	1744			
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	OTHER P	RIO	R ART - NON P	ATENT LITERATU	RE DOCUMENTS			
Examiner Initials	Cite No.1		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
	Ъ		Samuel Boateng et al., Peptides Bound to Silicone Membranes					

	Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²		
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			First Named Inventor	SHUICHI TAKAYAMA ET	AL.			
			Group Art Unit	1744				
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Sheet	3	of 3	Attorney Docket Number	UOM 0272 PUSP				
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